

September 2010

FDMS3604S Dual N-Channel PowerTrench[®] MOSFET N-Channel: 30 V, 30 A, 6.8 m Ω N-Channel: 30 V, 40 A, 2.6 m Ω

Features

Q1: N-Channel

- Max $r_{DS(on)} = 6.8 \text{ m}\Omega \text{ at } V_{GS} = 10 \text{ V}, I_D = 13 \text{ A}$
- Max r_{DS(on)} = 9.8 mΩ at V_{GS} = 4.5 V, I_D = 11 A

Q2: N-Channel

- Max $r_{DS(on)}$ = 2.6 m Ω at V_{GS} = 10 V, I_D = 23 A
- Max $r_{DS(on)}$ = 3.5 m Ω at V_{GS} = 4.5 V, I_D = 21 A
- Low inductance packaging shortens rise/fall times, resulting in lower switching losses
- MOSFET integration enables optimum layout for lower circuit inductance and reduced switch node ringing
- RoHS Compliant

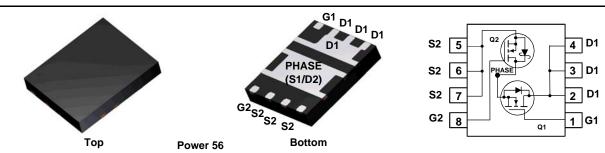


General Description

This device includes two specialized N-Channel MOSFETs in a dual PQFN package. The switch node has been internally connected to enable easy placement and routing of synchronous buck converters. The control MOSFET (Q1) and synchronous SyncFET (Q2) have been designed to provide optimal power efficiency.

Applications

- Computing
- Communications
- General Purpose Point of Load
- Notebook VCORE



MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

Symbol	Parameter		Q1	Q2	Units
V _{DS}	Drain to Source Voltage		30	30	V
V _{GS}	Gate to Source Voltage	(Note 3)	±20	±20	V
	Drain Current -Continuous (Package limited)	T _C = 25 °C	30	40	
I _D	-Continuous (Silicon limited)	T _C = 25 °C	60	130	
	-Continuous	T _A = 25 °C	13 ^{1a}	23 ^{1b}	A
	-Pulsed		40	100	
E _{AS}	Single Pulse Avalanche Energy		40 ⁴	112 ⁵	mJ
P	Power Dissipation for Single Operation	T _A = 25 °C	2.2 ^{1a}	2.5 ^{1b}	14/
P _D	Power Dissipation for Single Operation	T _A = 25 °C	1.0 ^{1c}	1.0 ^{1d}	W
T _J , T _{STG}	Operating and Storage Junction Temperature Range		-55 to	+150	°C

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	57 ^{1a}	50 ^{1b}	
R_{\thetaJA}	Thermal Resistance, Junction to Ambient	125 ^{1c}	120 ^{1d}	°C/W
$R_{\theta JC}$	Thermal Resistance, Junction to Case	3.5	2	

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
22CA N7CC	FDMS3604S	Power 56	13 "	12 mm	3000 units

Symbol	Parameter	Test Conditions	Туре	Min	Тур	Max	Units
Off Chara	acteristics						
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \ \mu A, \ V_{GS} = 0 \ V$ $I_D = 1 \ mA, \ V_{GS} = 0 \ V$		30 30			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, referenced to 25 °C $I_D = 10 \ m$ A, referenced to 25 °C	Q1 Q2		15 12		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 24 V, V_{GS} = 0 V$	Q1 Q2			1 500	μΑ μΑ
I _{GSS}	Gate to Source Leakage Current, Forwad	V _{GS} = 20 V, V _{DS} = 0 V	Q1 Q2			100 100	nA nA
On Chara	acteristics						
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \ \mu A$ $V_{GS} = V_{DS}, I_D = 1 \ m A$	Q1 Q2	1.1 1.1	2 1.8	2.7 3	V
			~ 1				
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, referenced to 25 °C $I_D = 10 \ m$ A, referenced to 25 °C	Q1 Q2		-6 -5		mV/°C
ΔTJ	Temperature Coefficient				-	6.8 9.8 9.2	
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	5	$I_{D} = 10 \text{ mA, referenced to } 25 \text{ °C}$ $V_{GS} = 10 \text{ V, } I_{D} = 13 \text{ A}$ $V_{GS} = 4.5 \text{ V, } I_{D} = 11 \text{ A}$	Q2		-5 5.2 7.5	9.8	mV/°C

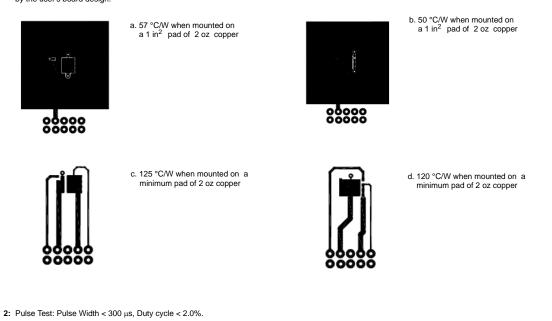
Dynamic Characteristics

C _{iss}	Input Capacitance	Q1: V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHZ	Q1 Q2		1340 3240	1785 4310	pF
C _{oss}	Output Capacitance	Q2:	Q1 Q2		485 1230	645 1635	pF
C _{rss}	Reverse Transfer Capacitance	V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHZ	Q1 Q2		53 103	80 155	pF
R _g	Gate Resistance		Q1 Q2	0.2 0.2	0.6 0.8	2.0 3.0	Ω

Switching Characteristics

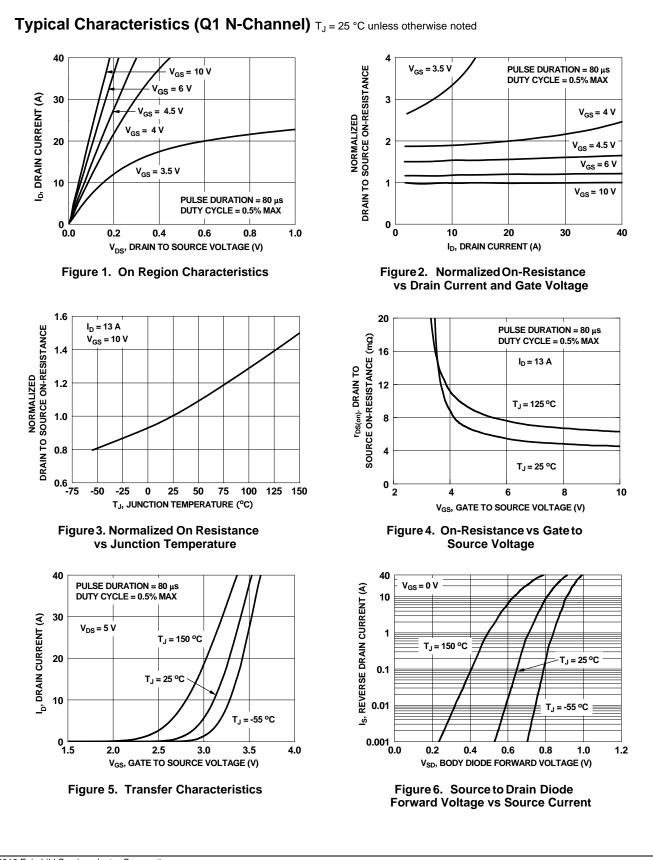
t _{d(on)}	Turn-On Delay Time			Q1 Q2	8.2 13	16 23	ns
t _r	Rise Time	Q1: V _{DD} = 15 V, I _D = 13	A, $R_{GEN} = 6 \Omega$	Q1 Q2	2.5 4.8	10 10	ns
t _{d(off)}	Turn-Off Delay Time	Q2:		Q1 Q2	20 31	32 50	ns
t _f	Fall Time	V _{DD} = 15 V, I _D = 23	A, $R_{GEN} = 6 \Omega$	Q1 Q2	2.2 3.4	10 10	ns
Qg	Total Gate Charge	$V_{GS} = 0$ V to 10 V	Q1	Q1 Q2	21 47	29 66	nC
Qg	Total Gate Charge	$V_{GS} = 0$ V to 4.5 V	V _{DD} = 15 V, I _D = 13 A	Q1 Q2	10 22	14 31	nC
Q _{gs}	Gate to Source Gate Charge		Q2 V _{DD} = 15 V,	Q1 Q2	3.9 9		nC
Q _{gd}	Gate to Drain "Miller" Charge		$V_{DD} = 13 V,$ $I_{D} = 23 A$	Q1 Q2	3.1 5.5		nC

Symbol	Parameter	Test Conditions	Туре	Min	Тур	Max	Units
Drain-Sou	urce Diode Characteristics						
N/	Source to Drain Diode Forward Voltage	$V_{GS} = 0 V, I_S = 13 A$ (Note 2)	Q1		0.8	1.2	V
V SD		$V_{GS} = 0 V, I_S = 23A$ (Note 2)	Q2		0.8	1.2	v
		Q1	Q1		25	40	
Lrr	Reverse Recovery Time	I _F = 13 A, di/dt = 100 A/μs	Q2		32	51	ns
0	Reverse Reservery Charge	Q2	Q1		9	18	~ ^ ^
Q _{rr} Reverse Recovery Charge		I _F = 23 A, di/dt = 300 A/μs	Q2		39	62	nC



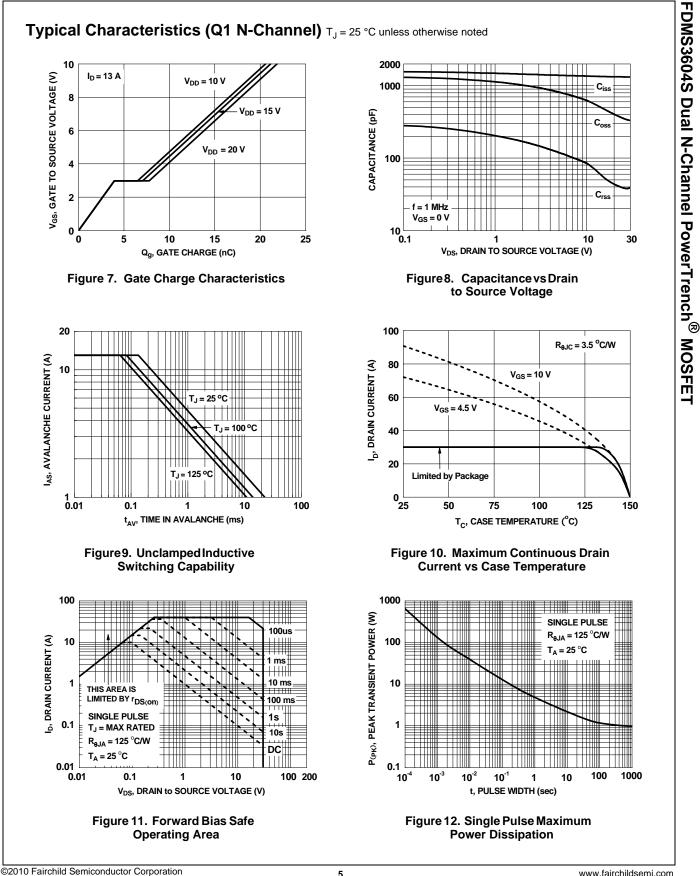
- 3: As an N-ch device, the negative Vgs rating is for low duty cycle pulse ocurrence only. No continuous rating is implied.
- 4: E_{AS} of 40 mJ is based on starting T_J = 25 °C; N-ch: L = 1 mH, I_{AS} = 9 A, V_{DD} = 27 V, V_{GS} = 10 V. 100% test at L= 0.3 mH, I_{AS} = 14 A.
- 5: E_{AS} of 112 mJ is based on starting T_J = 25 °C; N-ch: L = 1 mH, I_{AS} = 15 A, V_{DD} = 27 V, V_{GS} = 10 V. 100% test at L= 0.3 mH, I_{AS} = 22 A.

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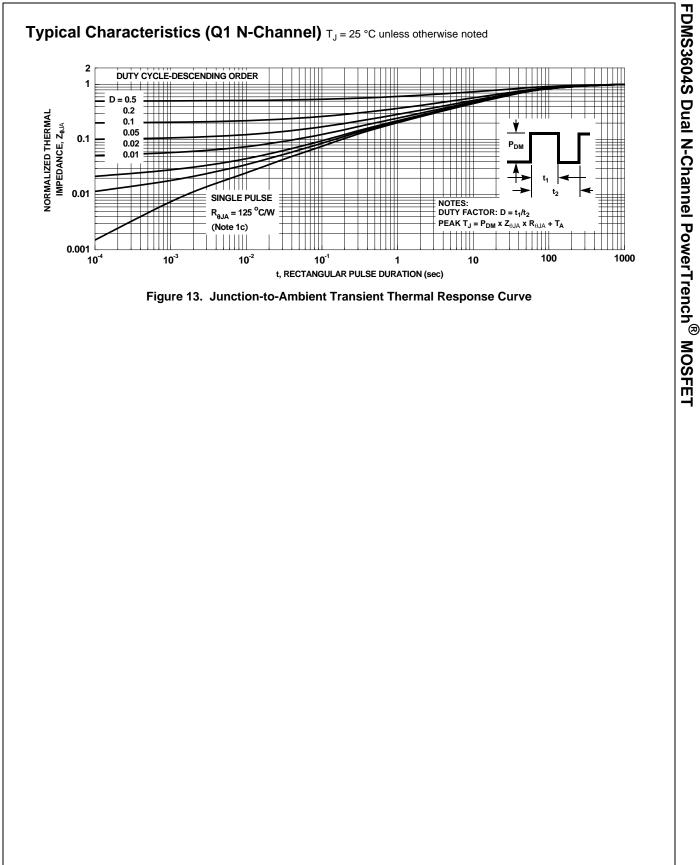


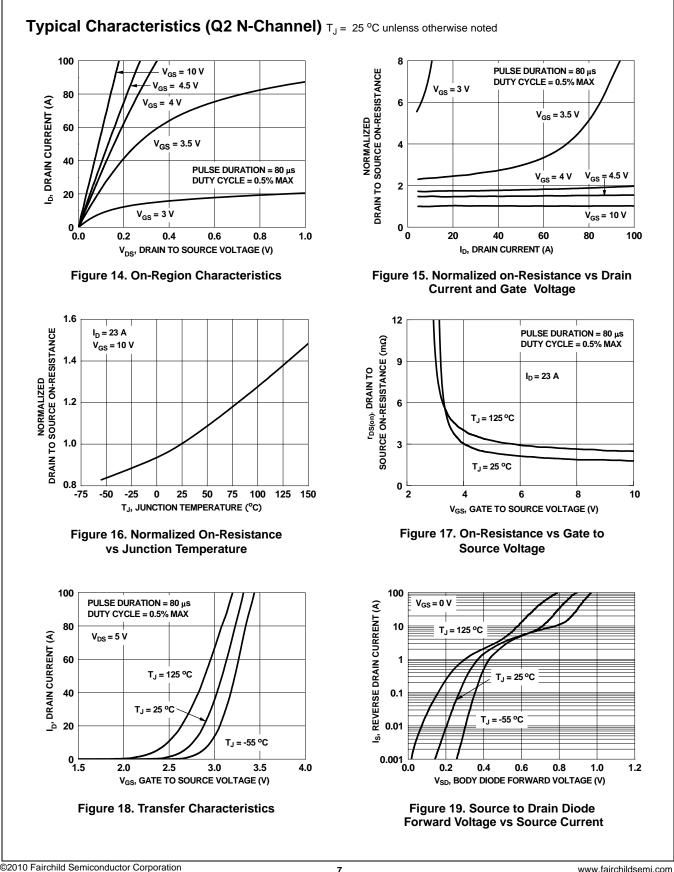
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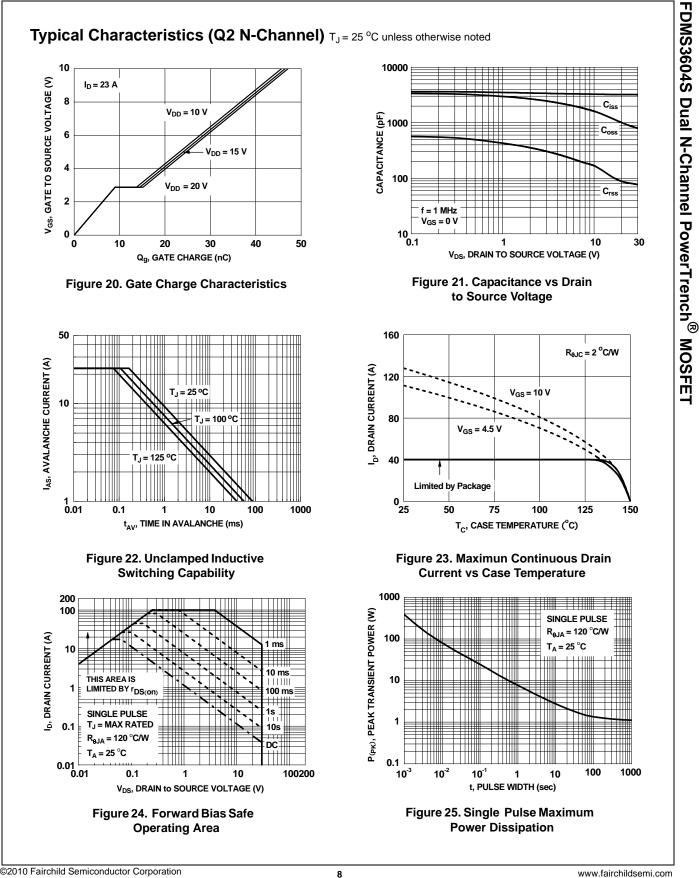


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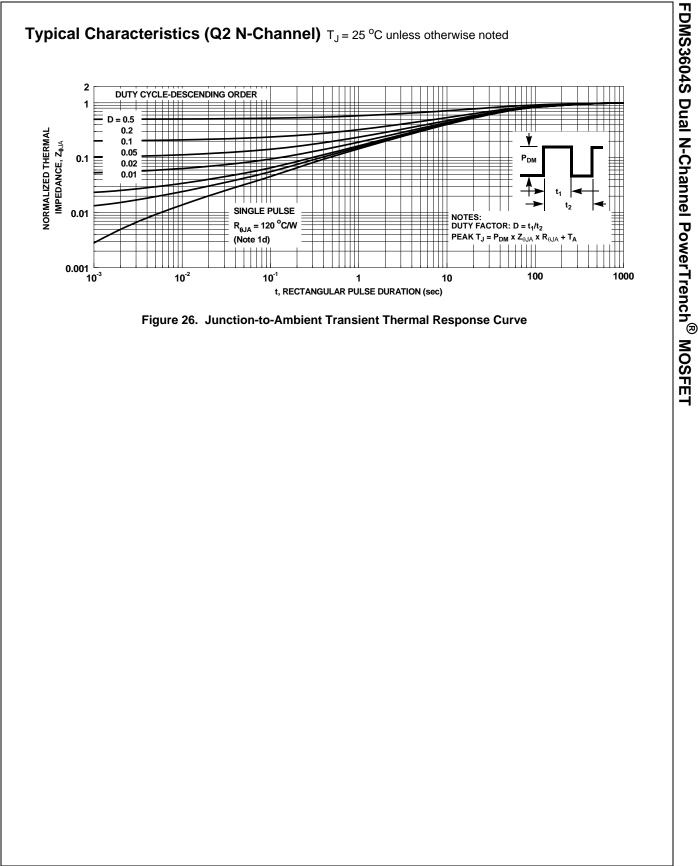




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Typical Characteristics (continued)

SyncFET Schottky body diode Characteristics

Fairchild's SyncFET process embeds a Schottky diode in parallel with PowerTrench MOSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 27 shows the reverse recovery characteristic of the FDMS3604S.

Figure 27. FDMS3604S SyncFET body diode reverse recovery characteristic

Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.

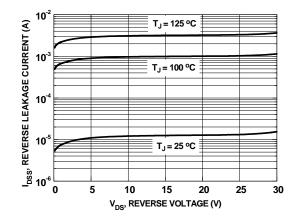
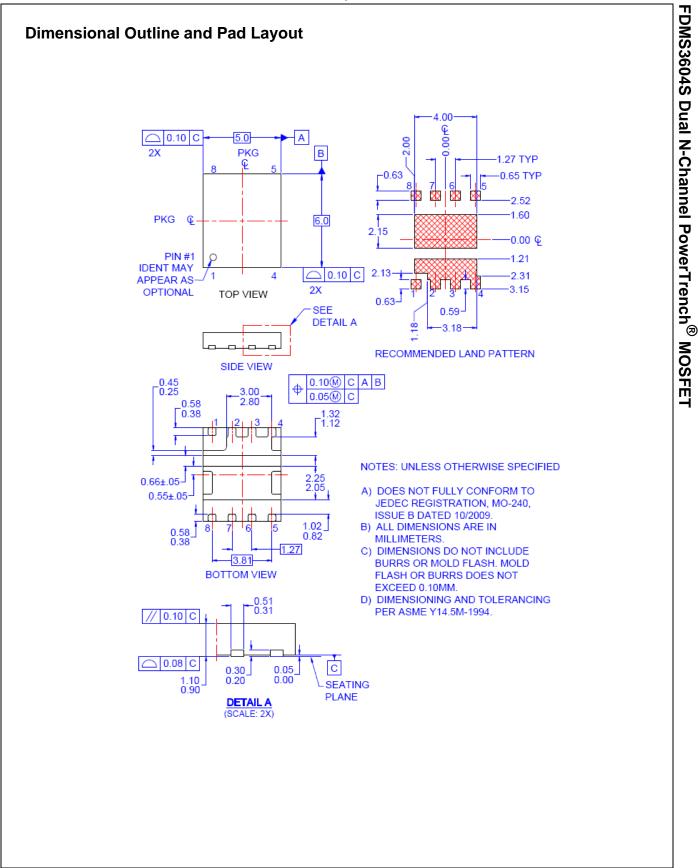
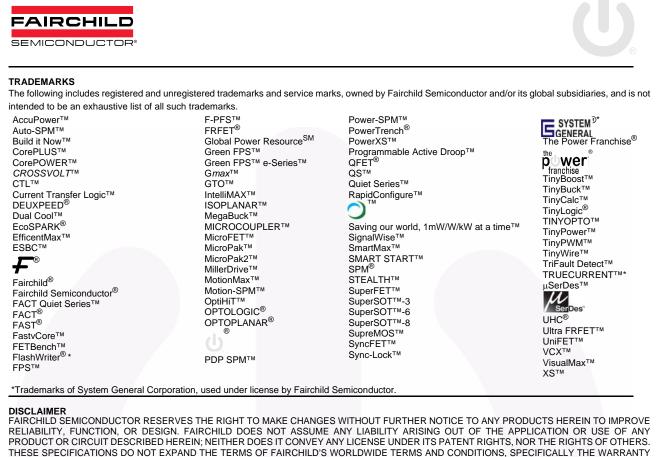


Figure 28. SyncFET body diode reverse leakage versus drain-source voltage

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